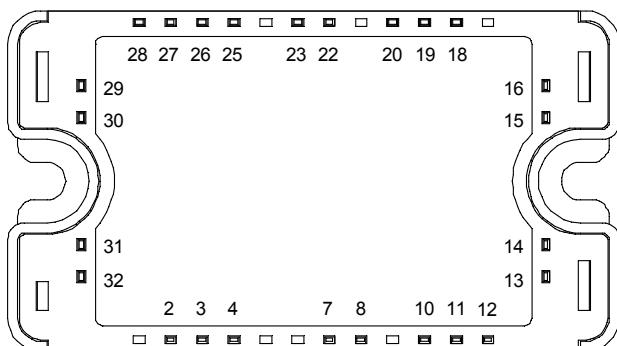
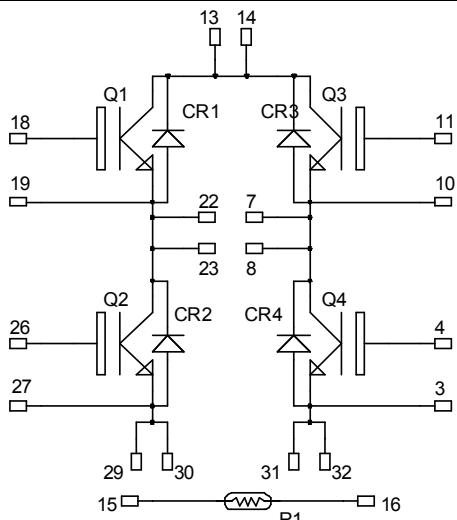


**Full bridge  
Trench + Field Stop IGBT4  
Power module**

**V<sub>CES</sub> = 1200V  
I<sub>C</sub> = 60A @ T<sub>c</sub> = 80°C**



All multiple inputs and outputs must be shorted together  
Example: 13/14 ; 29/30 ; 22/23 ...

#### Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage	1200	V
I <sub>C</sub>	Continuous Collector Current	T <sub>C</sub> = 25°C	A
		T <sub>C</sub> = 80°C	
I <sub>CM</sub>	Pulsed Collector Current	T <sub>C</sub> = 25°C	100
V <sub>GE</sub>	Gate – Emitter Voltage	±20	V
P <sub>D</sub>	Maximum Power Dissipation	T <sub>C</sub> = 25°C	280
RBSOA	Reverse Bias Safe Operating Area	T <sub>j</sub> = 150°C	100A @ 1100V

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

#### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### Features

- Trench + Field Stop IGBT 4 Technology
  - Low voltage drop
  - Low leakage current
  - Low switching losses
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
  - Symmetrical design
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

#### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive TC of VCESat
- Each leg can be easily paralleled to achieve a phase leg of twice the current capability
- RoHS compliant

All ratings @  $T_j = 25^\circ\text{C}$  unless otherwise specified

**Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0\text{V}$ , $V_{CE} = 1200\text{V}$				250	$\mu\text{A}$
$V_{CE(\text{sat})}$	Collector Emitter saturation Voltage	$V_{GE} = 15\text{V}$	$T_j = 25^\circ\text{C}$		1.85	2.25	$\text{V}$
		$I_C = 50\text{A}$	$T_j = 150^\circ\text{C}$		2.25		
$V_{GE(\text{th})}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 1.6\text{mA}$		5.0	5.8	6.5	$\text{V}$
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20\text{V}$ , $V_{CE} = 0\text{V}$				400	$\text{nA}$

**Dynamic Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$C_{ies}$	Input Capacitance	$V_{GE} = 0\text{V}$ $V_{CE} = 25\text{V}$ $f = 1\text{MHz}$			2770		$\text{pF}$
$C_{oes}$	Output Capacitance				205		
$C_{res}$	Reverse Transfer Capacitance				160		
$Q_G$	Gate charge	$V_{GE} = \pm 15\text{V}$ ; $V_{CE} = 600\text{V}$ $I_C = 50\text{A}$			0.38		$\mu\text{C}$
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching ( $25^\circ\text{C}$ ) $V_{GE} = \pm 15\text{V}$ $V_{CE} = 600\text{V}$ $I_C = 50\text{A}$ $R_G = 8.2\Omega$			130		$\text{ns}$
$T_r$	Rise Time				20		
$T_{d(off)}$	Turn-off Delay Time				300		
$T_f$	Fall Time				45		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching ( $150^\circ\text{C}$ ) $V_{GE} = \pm 15\text{V}$ $V_{CE} = 600\text{V}$ $I_C = 50\text{A}$ $R_G = 8.2\Omega$			150		$\text{ns}$
$T_r$	Rise Time				35		
$T_{d(off)}$	Turn-off Delay Time				350		
$T_f$	Fall Time				80		
$E_{on}$	Turn-on Switching Energy	$V_{GE} = \pm 15\text{V}$ $V_{CE} = 600\text{V}$ $I_C = 50\text{A}$ $R_G = 8.2\Omega$		$T_j = 25^\circ\text{C}$	3.8		$\text{mJ}$
$E_{off}$	Turn-off Switching Energy			$T_j = 150^\circ\text{C}$	5.5		
$I_{sc}$	Short Circuit data	$V_{GE} \leq 15\text{V}$ ; $V_{Bus} = 900\text{V}$ $t_p \leq 10\mu\text{s}$ ; $T_j = 150^\circ\text{C}$			200		$\text{A}$

**Reverse diode ratings and characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit		
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			1200			$\text{V}$		
$I_{RM}$	Maximum Reverse Leakage Current	$V_R = 1200\text{V}$		$T_j = 25^\circ\text{C}$		100	$\mu\text{A}$		
				$T_j = 125^\circ\text{C}$		500			
$I_F$	DC Forward Current			$T_c = 80^\circ\text{C}$		60	$\text{A}$		
$V_F$	Diode Forward Voltage			$I_F = 60\text{A}$		2.5	3		
				$I_F = 120\text{A}$		3	$\text{V}$		
				$I_F = 60\text{A}$	$T_j = 125^\circ\text{C}$	1.8			
$t_{rr}$	Reverse Recovery Time	$I_F = 60\text{A}$ $V_R = 800\text{V}$ $di/dt = 200\text{A}/\mu\text{s}$		$T_j = 25^\circ\text{C}$		265	$\text{ns}$		
				$T_j = 125^\circ\text{C}$		350			
$Q_{rr}$	Reverse Recovery Charge			$T_j = 25^\circ\text{C}$		560	$\text{nC}$		
				$T_j = 125^\circ\text{C}$		2890			



### Thermal and package characteristics

Symbol	Characteristic		Min	Typ	Max	Unit
$R_{thJC}$	Junction to Case Thermal Resistance	IGBT			0.53	°C/W
		Diode			0.9	
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t = 1 min, I isol < 1mA, 50/60Hz	2500				V
$T_J$	Operating junction temperature range	-40		175		
$T_{STG}$	Storage Temperature Range	-40		125		°C
$T_C$	Operating Case Temperature	-40		100		
Torque	Mounting torque	To heatsink	M4	2.5	4.7	N.m
Wt	Package Weight				110	g

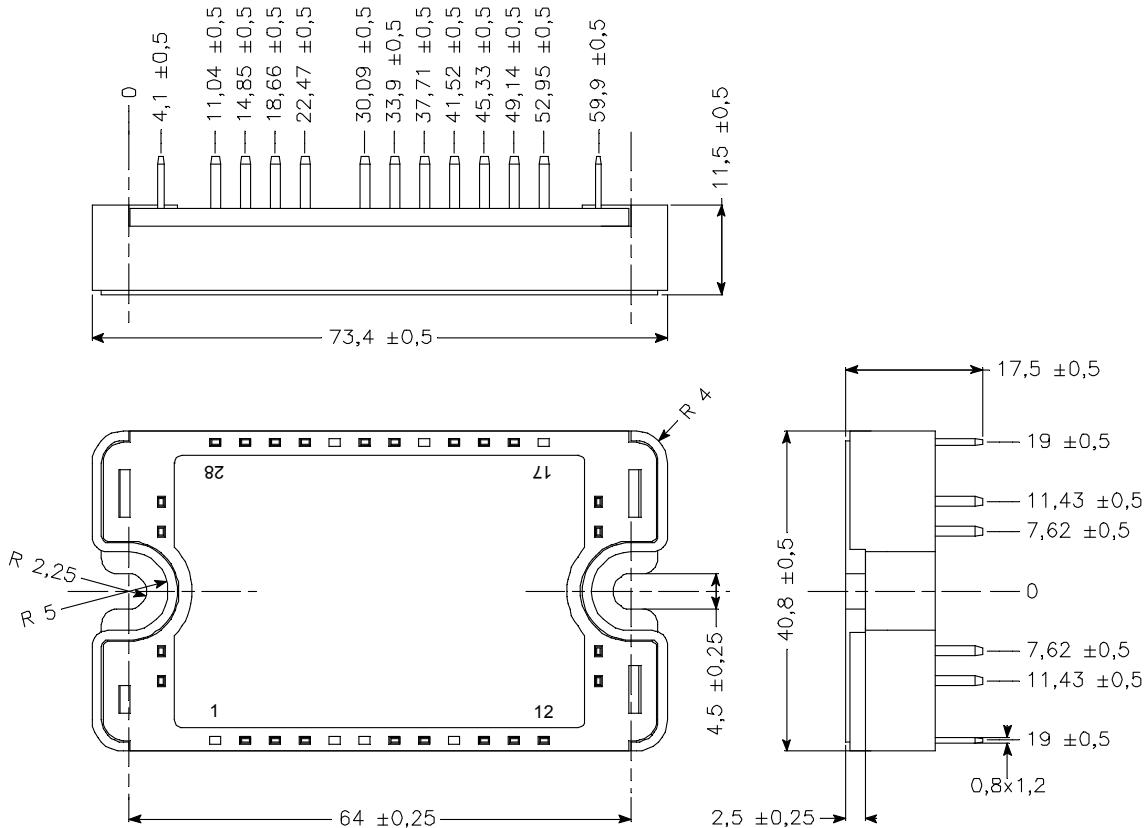
**Temperature sensor NTC** (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic		Min	Typ	Max	Unit
$R_{25}$	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		$T_C=100^\circ\text{C}$		4		%

$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

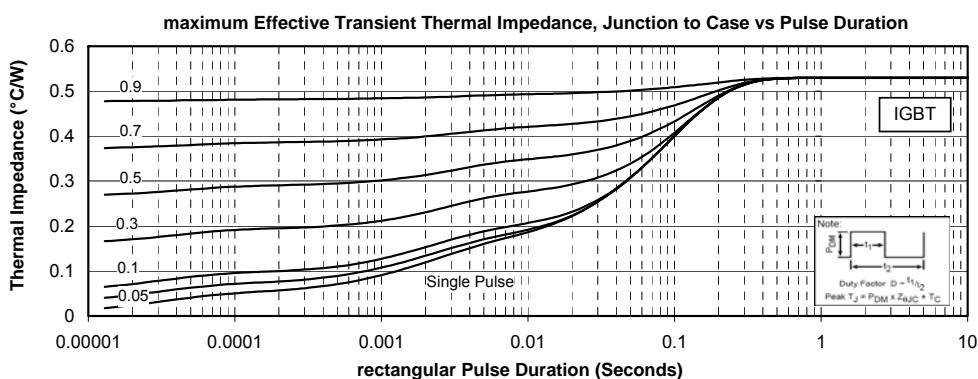
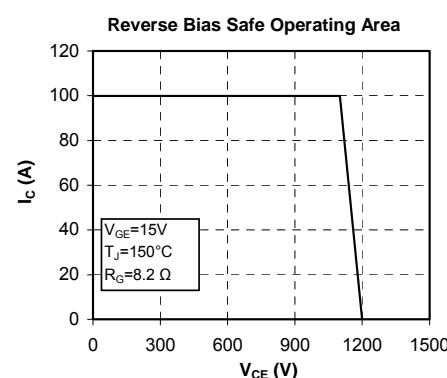
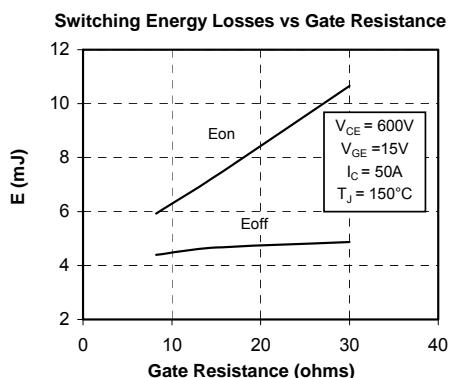
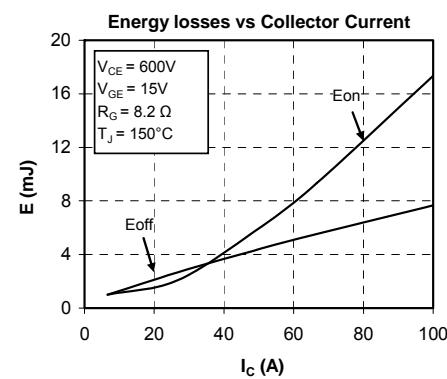
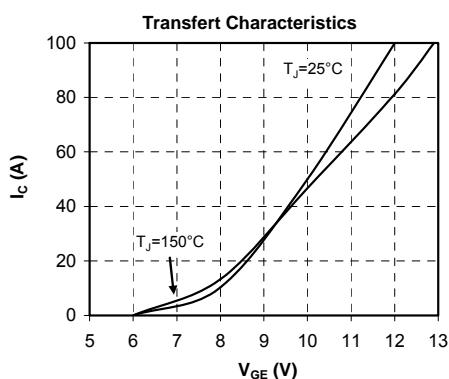
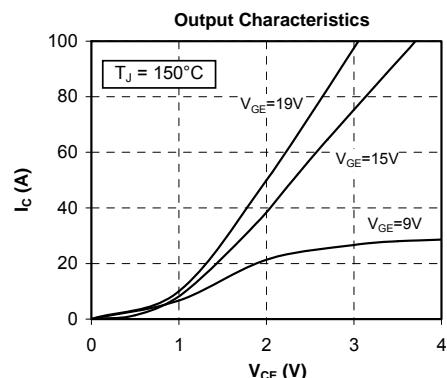
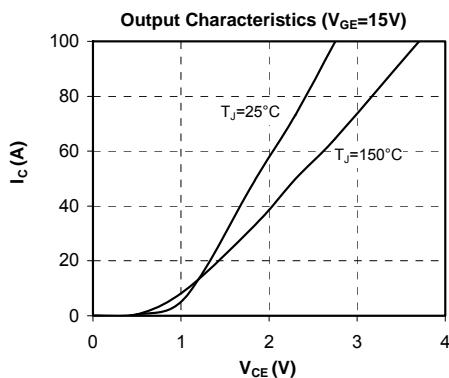
### SP3 Package outline (dimensions in mm)

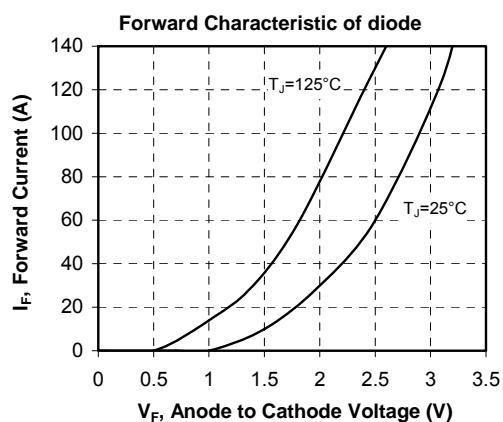
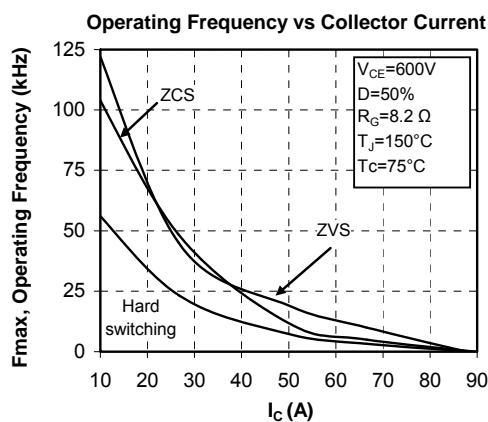


See application note 1901 - Mounting Instructions for SP3 Power Modules on [www.microsemi.com](http://www.microsemi.com)

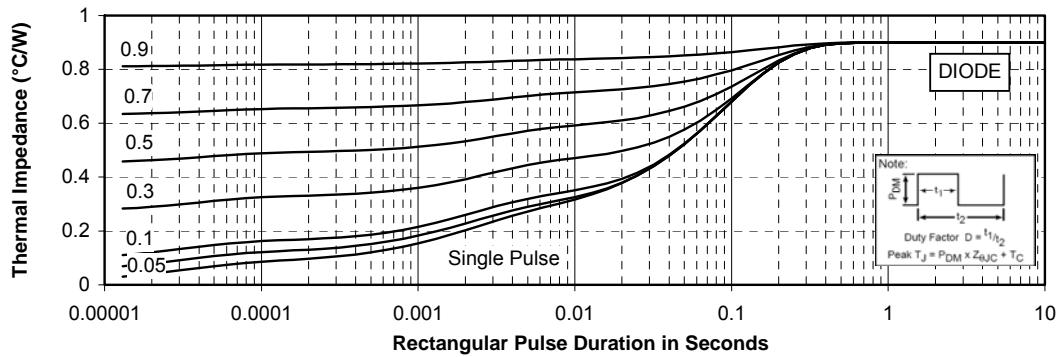


### Typical Performance Curve





#### maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



**Microsemi reserves the right to change, without notice, the specifications and information contained herein**

Microsemi's products are covered by one or more of U.S patents 4,895,810 5,045,903 5,089,434 5,182,234 5,019,522 5,262,336 6,503,786 5,256,583 4,748,103 5,283,202 5,231,474 5,434,095 5,528,058 6,939,743 7,352,045 5,283,201 5,801,417 5,648,283 7,196,634 6,664,594 7,157,886 6,939,743 7,342,262 and foreign patents. U.S and Foreign patents pending. All Rights Reserved.